## Notice of References Cited Application/Control No. 10/742,933 Examiner William Boddie Applicant(s)/Patent Under Reexamination MIYACHI ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,488,389	01-1996	Nakanishi et al.	345/67Ó
	В	US-6,219,017	04-2001	Shimada et al.	345/88
	С	US-4,937,667	06-1990	Choquet et al.	. 348/448
	D	US-6,909,472	. 06-2005	Gadeyne et al.	348/750
	Ε	US-6,333,727	12-2001	Mizumaki, Hidetaka	345/690
	F	US-6,295,091	09-2001	Huang, Samson	348/448
	G	US-2003/0090449	05-2003	Arimoto et al.	345/87
	Н	US-6,507,346	01-2003	Otera, Atsushi	345/606
	1	US-6,567,097	05-2003	Iwaki, Tsutomu	345/603
	J	US-RE35,093	11-1995	Wang et al.	348/413.1
	к	US-			
	L	US-			
	м	US-			

## **FOREIGN PATENT DOCUMENTS**

*	•	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

NON TAILUT DOGULLATO								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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